### SN5400, SN54LSOO, SN54SOO, SN7400, SN74LSOO, SN74SOO QUADRUPLE 2-INPUT POSITIVE-NAND GATES December 1983-Revised March 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

#### description

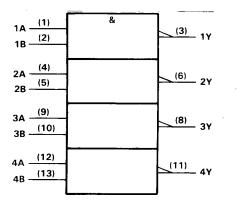
These devices contain four independent 2-input-NAND gates.

The SN5400, SN54LS00, and SN54S00 are characterized for operation over the full military temperature range of -55 °C to 125 °C. The SN7400, SN74LS00, and SN74S00 are characterized for operation from 0 °C to 70 °C.

#### FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
A	В	Y
н	н	L
L	х	н
х	L	н

logic symbol<sup>†</sup>



<sup>†</sup>This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

-----

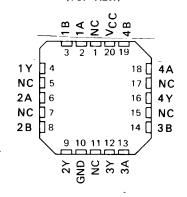
SN5400 . . . J PACKAGE SN54LS00, SN54S00 . . . J OR W PACKAGE SN7400 . . . N PACKAGE SN74LS00, SN74S00 . . . D OR N PACKAGE (TOP VIEW)

1A	ſ	1	U 14	þ	Vcc
1B	С	2	13	þ	4 B
1Y	С	3	12	þ	4A
2A		4	11	þ	4 Y
2B		5	10	Ь	3 B
2Y	Ц	6	9		3A
GND		7	8	כ	3 Y

SN5400	W PACKAGE
(TOP	VIEW)

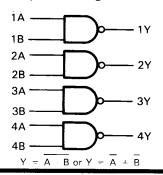
	,
	U 14] 4 Y
1 B 🗖 2	13 <b>4 B</b>
1 Y 🗖 3	12 <b>  4 A</b>
Vcc []₄	11 GND
2 Y 🗍 5	10 <b>] 3 B</b>
2A [ 6	9 🗍 3 A
2 B 🔤 7	8 <b>] 3</b> Y

SN54LS00, SN54S00 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

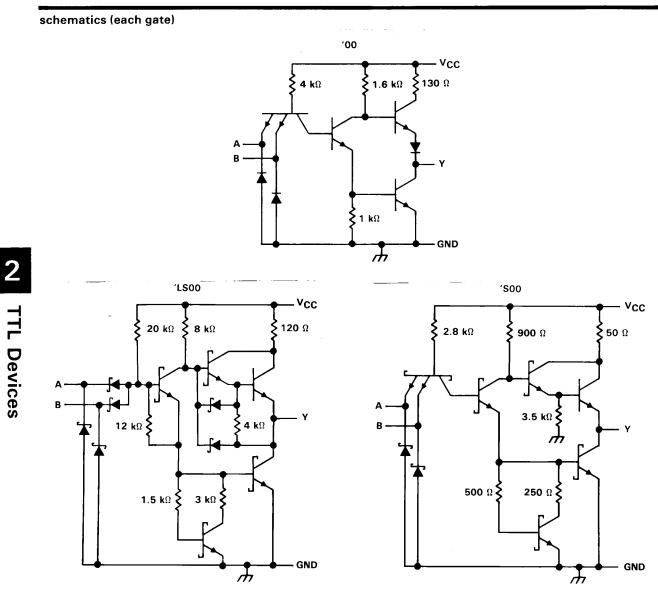


1 mg

**TTL Devices** 

## SN5400, SN54LS00, SN54S00, SN7400, SN74LS00, SN74S00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

1



Resistor values shown are nominal.

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		7 V
Input voltage: '00, 'S00		5.5 V
′LS00		7V
Operating free-air temperature range	: SN54'	-55°C to 125°C
	SN74'	0°C to 70°C
Storage temperature range		-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.



# SN5400, SN7400 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

recommended operating conditions

			SN5400		SN7400			UNIT
		MIN	MIN NOM MAX MIN NOM		мах			
V <sub>CC</sub> Supply volta	ge	4.5	5	5.5	4.75	5	5.25	V
VIH High-level in	put voltage	2			2			V
VIL Low-level in	put voltage			0.8			0.8	v
10H High-level of	utput current			- 0.4			- 0.4	mA
IOL Low-level of	utput current			16			16	mA
T <sub>A</sub> Operating fr	ee-air temperature	- 55		125	0		70	°c

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

----

		TEST CONDITIONS †			SN5400			SN7400			
PARAMETER				MIN	TYP‡	МАХ	MIN	TYP‡	МАХ	UNIT	
VIK	V <sub>CC</sub> = MIN,	l <sub>l</sub> = – 12 mA				- 1.5			- 1.5	V	
	V <sub>CC</sub> = MIN,	VIL = 0.8 V,	I <sub>OH</sub> = - 0.4 mA	2.4	3.4		2.4	3.4		V	
VOL	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	I <sub>OL</sub> = 16 mA		0.2	0.4		0.2	0.4	v	
	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 5.5 V				1			1	mA	
	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 2.4 V				40		_	40	μA	
	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V	•			- 1.6			- 1.6	mA	
IOS §	V <sub>CC</sub> = MAX			- 20		- 55	- 18		- 55	mA	
Іссн	V <sub>CC</sub> = MAX,	V1 = 0 V			4	8		4	8	mA	
ICCL	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 4.5 V	<u> </u>		12	22		12	22	mA	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^{\circ}C$ . § Not more than one output should be shorted at a time.

### switching characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	ТҮР	мах	UNIT
tPLH					11	22	ns
<sup>t</sup> PHL	A or B	Y	$R_{L} = 400 \ \overline{\Omega}, \qquad C_{L} = 15 \ pF$		7	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



# SN54LS00, SN74LS00 **QUADRUPLE 2 INPUT POSITIVE NAND GATES**

### 【点**户**4月2 】 TSTY IL UNO CAR CALLAR

### recommended operating conditions

			SN54LS00			SN74LS00		
		MIN	NOM	МАХ	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	v
VIH	High-level input voltage	2			2			v
VIL	Low-level input voltage			0.7			0.8	v
юн	High-level output current			- 0.4			- 0.4	mA
<sup>I</sup> OL	Low-level output current			4			8	mA
Т <sub>А</sub>	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDIT			SN54LS	00		· · · · -		
TANAWETEN		TEST CONDIT	TONST	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V <sub>CC</sub> = MIN,	lj = – 18 mA				- 1.5			- 1.5	v
∨он	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,	<sup>I</sup> OH <sup>=</sup> - 0.4 mA	2.5	3.4		2.7	3.4		v
VOL	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	l <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	
•0L	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	IOL = 8 mA					0.35	0.5	v
ų	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 7 V				0.1			0.1	mA
ін	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 2.7 V				20			20	μA
կլ	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V				- 0.4			- 0.4	mA
IOS§	V <sub>CC</sub> = MAX			- 20		- 100	- 20		- 100	mA
Іссн	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0 V			0.8	1.6		0.8	1.6	mA
ICCL	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 4.5 V	· · ·		2.4	4.4		2.4	4.4	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 $\ddagger$  All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25<sup>o</sup>C § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

PARAMETER	FROM (INPUT)	то (OUTPUT)	TEST CONDITIONS	MIN TYP	MAX	UNIT
<sup>t</sup> PLH	A or B	×		9	15	ns
<sup>t</sup> PHL		•	$R_L = 2 k\Omega$ , $C_L = 15 pF$	10	15	ns

### switching characteristics, $V_{CC} = 5 V$ , $T_{\Delta} = 25^{\circ}C$ (see note 2)

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

. . . . . . . .



# SN54S00, SN74S00 QUADRUPLE 2-INPUT POSITIVE-NAND GATES

recommended operating conditions

		SN54S0	0	SN74S00			UNIT
	MIN	NOM	мах	MIN	NOM	МАХ	ONIT
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	v
VIH High-level input voltage	2			2			v
VIL Low-level input voltage			0.8			0.8	V
IOH High-level output current			- 1			- 1	mA
IOL Low-level output current			20			20	mA
T <sub>A</sub> Operating free-air temperature	- 55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			SN54S00			SN74S00		
	TEST CONDITIONS †	MIN	TYP‡	MAX	MIN	TYP‡	мах	UNIT
VIK	V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA			-1.2			-1.2	V
VOH	V <sub>CC</sub> = MIN, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -1 mA	2.5	3.4		2.7	3.4		v
VOL	$V_{CC} = MIN$ , $V_{IH} = 2 V$ , $I_{OL} = 20 mA$			0.5			0.5	V
	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			1			1	mA
 I <sub>IH</sub>	$V_{CC} = MAX, V_1 = 2.7 V$			50			50	μA
ιL	V <sub>CC</sub> = MAX, V <sub>1</sub> = 0.5 V			2			-2	mA
IOS§	V <sub>CC</sub> = MAX	-40		-100	40		-100	mA
ІССН	V <sub>CC</sub> = MAX, V <sub>1</sub> = 0 V		10	16		10	16	mA
	V <sub>CC</sub> = MAX, V <sub>I</sub> = 4.5 V		20	36		20	36	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^{\circ}C$ . § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

# switching characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	түр	МАХ	UNIT
<sup>t</sup> PLH	A or B	Y	R <sub>L</sub> = 280 Ω,	C <sub>L</sub> = 15 pF		3	4.5	ns
<sup>t</sup> PHL						3	5	ns
<sup>t</sup> PLH			RL = 280 Ω,	С <sub>L</sub> = 50 рF		4.5		ns
tPHL						5		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



#### **IMPORTANT NOTICE**

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated